Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/071,263	CAIA, JEAN-MICHEL	
Examiner	Art Unit	
PHUC H. TRAN	2616	

PHUC H. TRAN

SEARCHED				
Class	Subclass	Date	Examiner	
370	229-235 351-370 395.51	11/16/2005	РТ	
above	udated	5/18/2006	PT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	11/16/2005	PT	
Consulted with Dang Ton	11/15/2005	PT	
370/503-520(text search only)	5/18/2006	PT	
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